

**Search Notes****Application/Control No.**

10/708,829

**Examiner**

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**Applicant(s)/Patent under Reexamination**

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**Art Unit**

2635

**SEARCHED**

Class	Subclass	Date	Examiner
340	5.53	5/19/2006	NN
340	5.2	5/19/2006	NN
340	5.4+	5/19/2006	NN
340	5.52	5/19/2006	NN
340	5.6	5/19/2006	NN
340	5.8+	5/19/2006	NN
340	10.1	5/19/2006	NN
340	10.4-10.5	5/19/2006	NN
235	379	5/19/2006	NN
235	380	5/19/2006	NN
235	492	5/19/2006	NN
705	35,54,76	5/19/2006	NN
705	186,194	12/10/2005	NN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search East: USPAT; US-PUB; EPO;JPO and Derwent. (UPDATED SEARCH)	5/19/2006	NN